

Notice of References Cited	Application/Control No. 10/717,497	Applicant(s)/Patent Under Reexamination SAINT ETIENNE ET AL.	
	Examiner Albert T. Chou	Art Unit 2616	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,282,669	08-2001	Imanaka et al.	714/4
	B	US-6,188,689	02-2001	Katsube et al.	370/389
	C	US-2006/0107108 A1	05-2006	Geng et al.	714/011
	D	US-5,379,278	01-1995	Safadi, Reem B.	370/221
	E	US-4,780,869	10-1988	Engdahl et al.	370/228
	F	US-6,766,482	07-2004	Yip et al.	714/717
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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